PROCEEDINGS OF SPIE

Advanced Optical Imaging Technologies

Xiao-Cong Yuan Kebin Shi Michael G. Somekh Editors

12–13 October 2018 Beijing, China

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Published by SPIE

Volume 10816

Proceedings of SPIE 0277-786X, V. 10816

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Advanced Optical Imaging Technologies, edited by Xiao-Cong Yuan, Kebin Shi, Michael G. Somekh, Proc. of SPIE Vol. 10816, 1081601 · © 2018 SPIE CCC code: 0277-786X/18/\$18 · doi: 10.1117/12.2520959

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Please use the following format to cite material from these proceedings:

Author(s), "Title of Paper," in Advanced Optical Imaging Technologies, edited by Xiao-Cong Yuan, Kebin Shi, Michael G. Somekh, Proceedings of SPIE Vol. 10816 (SPIE, Bellingham, WA, 2018) Sevendigit Article CID Number.

ISSN: 0277-786X

ISSN: 1996-756X (electronic)

ISBN: 9781510622302

ISBN: 9781510622319 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

SPIE.org

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